



RADIO TEST REPORT

Test Report No.: 30FE0016-SH-01-A

Applicant : CANON INC.
Type of Equipment : Wireless LAN Module
Model No. : K30326
FCC ID : AZDK30326
Test regulation : FCC Part15 Subpart C: 2009
Test result : Complied

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Date of test: January 28, 29 and February 1-3, 2010

Tested by: T. Arai
Tatsuya Arai
EMC Service

Approved by: I. Isozaki
Ichiro Isozaki
Group Leader of Shonan EMC lab.

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1 Applicant information

Company Name : CANON INC.
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Telephone Number : +81-3-3758-2111
Contact Person : Takahito Kamiya

2 Equipment under test (E.U.T.)

2.1 Identification of E.U.T.

Type of Equipment : Wireless LAN Module
Model No. : K30326
Serial No. : A0011
Rating : DC3.465V
Country of Mass-production : Thailand
Condition of EUT : Production prototype
(Not for Sale: This sample is equivalent to mass-produced items.)
Modification of EUT : No modification by the test lab.
Receipt Date of Sample : January 27, 2010

2.2 Product description

Model: K30326 (referred to as the EUT in this report) is a Wireless LAN Module.

Equipment type : Transceiver
Frequency of operation : 11b,11g, and 11n-20 : 2412-2462MHz
11n-40 : 2422-2452MHz
Clock frequency : 40MHz
Bandwidth & channel spacing : 11b,11g, and 11n-20
Bandwidth : 20MHz
Channel spacing : 5MHz
11n-40
Bandwidth : 40MHz
Channel spacing : 5MHz
Type of modulation : 11b : DSSS
11g, 11n : OFDM
Antenna type : Pattern antenna (meander)
Antenna gain with cable loss : 0.4dBi
Antenna connector type : -
ITU code : D1D, G1D
Operation temperature range : -5 to +55 deg.C.

FCC Part15.31 (e)

The Wireless LAN Module is provided with stable power supply (DC 3.1 V), therefore, the equipment complies power supply regulation.

FCC Part15.203 Antenna requirement

The antenna is not removable from the EUT. Therefore, the equipment complies with the antenna requirement of Section 15.203.

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3 Test specification, procedures and results

3.1 Test specification

Test specification : FCC Part 15 Subpart C: 2009, final revised on December 2, 2009
 Title : FCC 47CFR Part15 Radio Frequency Device Subpart C Intentional Radiators
 Section 15.207 Conducted limits
 Section 15.209 Radiated emission limits, general requirements
 Section 15.247 Operation within the bands 902-928MHz, 2400-2483.5MHz,
 and 5725-5850MHz

3.2 Procedures & Results

Item	Test Procedure	Specification	Remarks	Deviation	Worst Margin	Results
Conducted Emission	ANSI C63.4:2003 7. AC powerline conducted emission measurements	FCC 15.207	-	N/A	17.0dB (0.20609MHz, QP, 11n-40 Tx 2437MHz)	Complied
6dB Bandwidth	"Guidance on Measurement for Digital Transmission Systems Section 15.247" & ANSI C63.4:2003 13. Measurement of intentional radiators	FCC 15.247 (a)(2) & 15.209	Conducted	N/A	-	Complied
Maximum Peak Output Power	"Guidance on Measurement for Digital Transmission Systems Section 15.247" & ANSI C63.4:2003 13. Measurement of intentional radiators	FCC 15.247 (b)(3) & 15.209	Conducted	N/A	-	Complied
Out of Band Emission & Restricted Band Edges	"Guidance on Measurement for Digital Transmission Systems Section 15.247" & ANSI C63.4:2003 13. Measurement of intentional radiators	FCC 15.109, 15.247 (d) & 15.209	Conducted / Radiated	N/A	0.4dB (2483.500MHz, Horizontal, AV, 11g Tx 2462MHz)	Complied
Power Density	"Guidance on Measurement for Digital Transmission Systems Section 15.247" & ANSI C63.4:2003 13. Measurement of intentional radiators	FCC 15.247 (e)	Conducted	N/A	-	Complied

3.3 Addition to standard

Item	Test Procedure	Specification	Remarks	Worst Margin	Results
Occupied bandwidth (99%)	ANSI C63.4:2003 13. Measurement of intentional radiators RSS-Gen 4.6.1	RSS-Gen 4.6.1	Conducted	-	Complied

* Other than above, no addition, exclusion nor deviation has been made from the standard.

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3.4 Uncertainty

The following uncertainties have been calculated to provide a confidence level of 95% using a coverage factor k=2.

Item	Frequency range	No.1 SAC ^{*1} /SR ^{*2} (±)	No.2 SAC/SR (±)	No.3 SAC/SR (±)
Conducted emission (AC Mains) AMN/LISN	150kHz-30MHz	3.0 dB	2.6 dB	3.1 dB
Radiated emission (Measurement distance: 3m)	30MHz-300MHz	4.6 dB	4.5 dB	4.9 dB
	300MHz-1GHz	4.5 dB	4.6 dB	5.1 dB
	1GHz-13GHz	3.9 dB	3.9 dB	4.0 dB
Radiated emission (Measurement distance: 1m)	13GHz-18GHz	4.8 dB	4.8 dB	4.8 dB
	18GHz-40GHz	4.2 dB	4.2 dB	4.2 dB

*1: SAC=Semi-Anechoic Chamber

*2: SR= Shielded Room is applied besides radiated emission

The data listed in this report meets the limits unless the uncertainty is taken into consideration.

Conducted emissions, Power Density Measurement (below 1GHz) uncertainty (with a 95% confidence level) for this test was: (±) 1.1dB

Conducted emissions, Power Density Measurement (1G-3GHz) uncertainty (with a 95% confidence level) for this test was: (±) 1.2dB

Conducted emissions, Power Density Measurement (3G-18GHz) uncertainty (with a 95% confidence level) for this test was: (±) 2.9dB

Conducted emissions Measurement (18G-26.5GHz) uncertainty (with a 95% confidence level) for this test was: (±) 3.4dB

Power Measurement uncertainty above 1GHz (with a 95% confidence level) for this test was: (±) 0.8dB

Bandwidth Measurement uncertainty (with a 95% confidence level) for this test was: (±) 5.4%

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3.5 Test location

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JAB Accreditation No. : RTL02610

No.1/ No.2/ No.3 anechoic chamber has been fully described in a report submitted to FCC office, and accepted on April 17, 2009 (Registration No.: 697847).

IC Registration No. : 2973D-1 (No1 anechoic chamber)
2973D-2 (No2 anechoic chamber)
2973D-3 (No3 anechoic chamber)

Test room	Width x Depth x Height (m)	Test room	Width x Depth x Height (m)
No.1 Semi-anechoic chamber	20.6 x 11.3 x 7.65 Maximum measurement distance: 10m	No.1 Shielded room	6.8 x 4.1 x 2.7
No.2 Semi-anechoic chamber	20.6 x 11.3 x 7.65 Maximum measurement distance: 10m	No.2 Shielded room	6.8 x 4.1 x 2.7
No.3 Semi-anechoic chamber	12.7 x 7.7 x 5.35 Maximum measurement distance: 5m	No.3 Shielded room	6.3 x 4.7 x 2.7
No.4 Full-anechoic chamber	8.1 x 5.1 x 3.55	No.4 Shielded room	4.4 x 4.7 x 2.7
		No.5 Shielded room	7.8 x 6.4 x 2.7
		No.6 Shielded room	7.8 x 6.4 x 2.7

3.6 Test setup, Data of EMI & Test instruments

Refer to Appendix 1 to 3.

4 System test configuration

4.1 Justification

The system was configured in typical fashion (as a customer would normally use it) for testing.

Mode	Remarks*
IEEE 802.11b (11b)	11Mbps, PN9
IEEE 802.11g (11g)	9Mbps, PN9
IEEE 802.11n-20: 2.4G Band	MCS 0, PN9
IEEE 802.11n-40: 2.4G Band	MCS 0, PN9
*The worst condition was determined based on the test result of Maximum Peak Output Power (Low Channel)	

The data setting for the test mode was set the burst rate as shown at page 48.

Test Item	Operating Mode	Tested frequency
Conducted Emission	11b Tx	2412MHz
Spurious Emission	11g Tx	2437MHz
6dB Bandwidth	11n-20 Tx	2462MHz
Maximum Peak Output Power	11n-40 Tx	2422MHz
Power Density		2437MHz
99% Occupied Bandwidth		2452MHz

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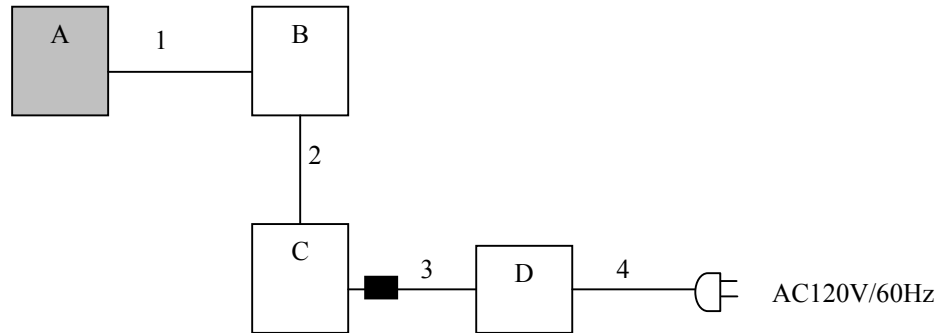
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4.2 Configuration and peripherals



■ : Standard Ferrite Core

* Test data was taken under worse case conditions.

Description of EUT and support equipment

No.	Item	Model number	Serial number	Manufacturer	Remarks
A	Wireless LAN Module	K30326	A0011	CANON INC.	EUT
B	INTERFACE BOARD	WLAN JOINT	0001	CANON INC.	
C	Laptop Computer	ThinkPad T42	L3-64H12	IBM	
D	AC adapter	08K8208	11S08K8208Z1Z9 MA5AB0U2	IBM	

List of cables used

No.	Name	Length (m)	Shield	
			Cable	Connector
1	Ribbon Cable	0.15	Unshielded	Unshielded
2	USB Cable	1.4	Shielded	Shielded
3	DC Cable	1.8	Unshielded	Unshielded
4	AC Cable	0.8	Unshielded	Unshielded

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5 Conducted emission

5.1 Operating environment

The test was carried out in No.3 shielded room.

Temperature : See test data
Humidity : See test data

5.2 Test configuration

EUT was placed on a platform of nominal size, 1m by 1.5m, raised 80cm above the conducting ground plane. The table is made of Styrofoam and covered with polyvinyl chloride. That has very low permittivity. The rear of tabletop was located 40cm to the vertical conducting plane. The rear of EUT was aligned and was flushed with rear of tabletop. All other surfaces of tabletop were at least 80cm from any other grounded conducting surface. EUT was located 80cm from LISN. They were folded back and for the forming a bundle 30cm to 40cm long and were hanged at a 40cm height to the ground plane. Photographs of the set up are shown in Appendix 1.

5.3 Test conditions

Frequency range : 0.15 - 30MHz
EUT position : Table top

5.4 Test procedure

The AC Mains Terminal Continuous disturbance Voltage had been measured with the EUT within a screened room. The EUT was connected to a Line Impedance Stabilization Network (LISN). An overview sweep with peak detection has been performed. The measurements had been performed with a quasi-peak detector and if required, an average detector. The conducted emission measurements were made with the following detector of the test receiver.

Detector Type : Quasi-Peak/ Average
IF Bandwidth : 9kHz

5.5 Results

Summary of the test results : Pass

Date : February 3, 2010 Test engineer : Tatsuya Arai

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6 6dB bandwidth & Occupied bandwidth (99%)

Test procedure

The bandwidth was measured with a spectrum analyzer connected to the antenna port.

Summary of the test results: Pass

Date : February 2, 2010

Test engineer : Tatsuya Arai

7 Maximum peak output power

Test procedure

The Maximum Peak Output Power was measured with a power meter connected to the antenna port.

Summary of the test results: Pass

Date : February 1, 2010

Test engineer : Tatsuya Arai

8 Out of band emissions (Antenna port conducted)

Test procedure

The Out of Band Emissions was measured with a spectrum analyzer connected to the antenna port.

In any 100kHz bandwidth outside the frequency band in which the spread spectrum intentional radiator is operating, the radio frequency power that is produced by the intentional radiator confirmed 20dB below that in the 100kHz bandwidth within the band that contains the highest level of the desired power, based on a radiated measurement.

Summary of the test results: Pass

Date : February 1, 2010

Test engineer : Tatsuya Arai

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9 Out of band emissions (Radiated)

9.1 Operating environment

The test was carried out in No.3 anechoic chamber.

9.2 Test configuration

EUT was placed on a platform of nominal size, 1m by 1.5m, raised 80cm above the conducting ground plane. The table is made of Styrofoam and covered with polyvinyl chloride. That has very low permittivity. Photographs of the set up are shown in Appendix 1.

9.3 Test conditions

Frequency range : 30MHz - 26GHz

9.4 Test procedure

The Radiated Electric Field Strength intensity has been measured with a ground plane and at a distance of 3m(below 13GHz) and 1m(above13GHz).

The measuring antenna height was varied between 1 and 4m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field intensity. The measurements were performed for both vertical and horizontal antenna polarization. Measurements were performed with QP, PK, and AV detector.

The radiated emission measurements were made with the following detector function of the test receiver.

Frequency	Below 1GHz	Above 1GHz
Instrument used	Test Receiver	Spectrum Analyzer *1)
Detector IF Bandwidth	QP: BW 120kHz	PK: RBW: 1MHz/VBW: 1MHz, AV RBW: 1MHz VBW: *2) (Pulse noise) 10Hz (No pulse noise)
Measuring antenna	Biconical (30-300MHz) Logperiodic (300MHz-1GHz)	Horn
Test distance	3m	3m(below 13GHz) 1m(above 13GHz)

*1) When using Spectrum analyzer, the test was made with adjusting span to zero by using peak hold.

*2) Used for the band edge of the harmonics that can be measured. The VBW is based on the inverse of the duty cycle (see P.48).

The carrier level and noise levels were confirmed at each position of X, Y and Z axes of EUT to see the position of maximum noise, and the test was made at the position that has the maximum noise.

Combinations of the worst case

Model	Worst position	
	Below 1GHz	Above 1GHz
EUT	Horizontal: Y, Vertical: Y	Horizontal: X, Vertical: Z (below 18GHz) Horizontal: Y, Vertical: Y (above 18GHz)

9.5 Band edge

Band edge level at 2400MHz is less than 20dB of peak point of the carrier. Refer to the data of Out of Band Emissions (Antenna Port Conducted). Band edge level at 2390MHz and 2483.5MHz is below the limits of FCC 15.209. Refer to the data of Radiated emission.

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9.6 Results

Summary of the test results : Pass

Date : January 28, 29 and February 1, 2010

Test engineer : Tatsuya Arai

10 Peak power density

Test procedure

The peak power density was measured with a spectrum analyzer connected to the antenna port.

Instrument used : Spectrum Analyzer *1)

RBW / VBW : 30kHz / 100kHz *2)

*1) PSD Option 1 of " Measurement of Digital Transmission Systems Operating under Section 15.247".

*2) The test was not performed at RBW : 3kHz that was stated in the Regulation.

However, the measurement value with RBW: 3kHz is less than the value of RBW: 30kHz and the test data met the limit with RBW: 30kHz.

Summary of the test results: Pass

Date : February 2, 2010

Test engineer : Tatsuya Arai

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APPENDIX 1: Photographs of test setup

Page 14	:	Conducted emission
Page 15	:	Radiated emission
Page 16	:	Pre-check of the worst position

APPENDIX 2: Test data

Page 17 - 28	:	Conducted emission
Page 29 - 31	:	6dB bandwidth
Page 32 - 35	:	Maximum peak output power
Page 36 - 48	:	Out of band emissions (Radiated)
Page 49 - 62	:	Out of band emissions (Antenna port conducted)
Page 63 - 65	:	Peak power density
Page 66 - 67	:	Occupied bandwidth

APPENDIX 3: Test instruments

Page 68	:	Test instruments
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